		CETECOM ICT Services consulting - testing - certification >>>>
		EPORT 1-4254/12-50-14
Testir	ng laboratory	Applicant
according to DIN EN Deutsche Akkreditierung The accreditation is procedures as stated in the registration number:	se 6 – 10 Germany 3 - 0 3 - 9075 Stecom.com .com boratory: (area of testing) is accredited ISO/IEC 17025 (2005) by the gsstelle GmbH (DAkkS) valid for the scope of testing the accreditation certificate with	Sony Mobile Communications AB Nya Vattentornet 22188 Lund / SWEDEN Phone: +46 46 19 30 00 Fax: +46 46 19 32 95 Contact: Håkan Sjöberg e-mail: <u>hakan.sjoberg@sonymobile.com</u> Phone: +46 46 19 35 59 Manufacturer Sony Mobile Communications AB Nya Vattentornet 22188 Lund / SWEDEN
47 CFR Part 15	Test sta Title 47 of the Code of Federa Part 15 - Radio frequency de Subpart E – UNII Devices	al Regulations; Chapter I vices
For further applied test s	standards please refer to section 3 of	this test report.
Kind of test item:	1/3/5/7/20; WLAN a/b/g/n; BT 3.1	RS 850/900/1800/1900; UMTS HSPA FDDI/V/VIII; LTE FDD
Model name: Frequency:	PM-0060-BV 5250 MHz – 5350 MHz ISM band (lowest channel 5260; highest c	
FCC ID: Technology tested:	(lowest channel 5200; highest c 5470 MHz – 5725 MHz ISM band (lowest channel 5500; highest c PY7PM-0060 WLAN (DFS client)	3
Antenna:	Integrated antenna	
Power Supply:	3.7 V DC by Li-Ion battery	

Test performed:

huhenbill

2012-10-01 Stefan Bös Senior Testing Manager Test report authorised:

Tolino

2012-10-01 Marco Bertolino Testing Manager



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2 General information

2.1 Notes

The test results of this test report relate exclusively to the test item specified in this test report. CETECOM ICT Services GmbH does not assume responsibility for any conclusions and generalisations drawn from the test results with regard to other specimens or samples of the type of the equipment represented by the test item. The test report may only be reproduced or published in full. Reproduction or publication of extracts from the report requires the prior written approval of CETECOM ICT Services GmbH.

2.2 Application details

Date of receipt of order:	2012-08-28
Date of receipt of test item:	2012-08-28
Start of test:	2012-09-24
End of test:	2012-09-24
Person(s) present during the test:	-/-

3 Test standard/s

Test standard	Version	Test standard description
47 CFR Part 15	2010-10	Title 47 of the Code of Federal Regulations; Chapter I Part 15 - Radio frequency devices Subpart E – UNII Devices

4 Test environment

Temperature:	T _{nom} T _{max} T _{min}	 +22 °C during room temperature tests +55 °C during high temperature tests -20 °C during low temperature tests
Relative humidity content:		39 %
Barometric pressure:		not relevant for this kind of testing
Power supply:	V _{nom} V _{max} V _{min}	 3.7 V DC by Li-Ion battery 4.1 V 3.3 V



5 Test item

:	GSM Mobile Phone GPRS/EGPRS 850/900/1800/1900; UMTS HSPA FDDI/V/VIII; LTE FDD 1/3/5/7/20; WLAN a/b/g/n; BT 3.1; RFID; FM Rx; A-GPS
:	PM-0060-BV
:	CB5A1KT6B1
:	AP1.1
:	9.0.D.0.164, s_atp_tsubasa_2_0_s
	5250 MHz – 5350 MHz ISM band 2
	(lowest channel 5260; highest channel 5320 MHz)
:	
	5470 MHz – 5725 MHz ISM band 3
	(lowest channel 5500; highest channel 5700 MHz)
:	OFDM
:	
:	FDMA
:	QPSK, 16 – & 64 – QAM
	ISM band 2: 4
•	ISM band 3: 11
:	Integrated antenna
:	3.7 V DC by Li-Ion battery
:	-20°C to +55 °C

6 Test laboratories sub-contracted

None



7 Summary of measurement results

\boxtimes	No deviations from the technical specifications were ascertained
	There were deviations from the technical specifications ascertained

TC Identifier	Description	Verdict	Date	Remark
DFS-Testing	CFR Part 15	Pass	2012-10-01	only DFS

Test Report Clause	Test Case	Temperature / Voltage	Pass	Fail	NA	NP	Remark
§15.407 (h)(2) (iii)	Channel move time and channel closing transmission time	nominal / nominal	\boxtimes				complies
§15.407 (h)(2) (iv)	Non-Occupancy Period	nominal / nominal	\boxtimes				complies

Note: NA = Not Applicable; NP = Not Performed



8 **RF** measurements

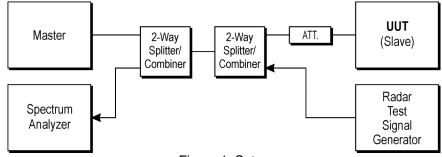
8.1 Description of test setup

8.1.1 Conducted measurements

<u>Setup</u>

Figure 1 shows a setup whereby the UUT is a RLAN device operating in slave mode, without Radar Interference Detection function. This setup also contains a RLAN device operating in master mode. The radar test signals are injected into the master device. The UUT (slave device) is associated with the master device.

Figure 1 shows an example







8.1.2 Parameters of DFS test signals

1. Interference Threshold values, Master or Client incorporating In-Service Monitoring

Maximum Transmit Power	Value (see note)		
≥ 200 mW	-64 dBm		
< 200 mW	-62 dBm		
Note 1: This is the level at the input of the receiver assuming a 0 dBi receive antenna Note 2: Throughout these test procedures an additional 1 dB has been added to the amplitude of the test transmission waveforms to account for variations in measurement equipment. This will ensure that the test signal is at or above the detection threshold level to trigger a DFS response.			

2. DFS Response requirement values

Parameter	Value			
Non-occupancy period	minimum 30 minutes			
Channel Availability Check Time	60 seconds			
Channel Move Time	10 seconds See Note 1.			
Channel Closing Transmission Time	200 milliseconds + an aggregate of 60 milliseconds over remaining 10 second period. See Notes 1 and 2.			
U-NII Detection Bandwidth	Minimum 80% of the 99% transmission power bandwidth See Note 3.			
Note 1: The instant that the Channel Move Time and the Channel Closing Transmission Time begins is as follows:				

• For the Short pulse radar Test Signals this instant is the end of the Burst.

• For the Frequency Hopping radar Test Signal, this instant is the end of the last radar Burst generated.

• For the Long Pulse radar Test Signal this instant is the end of the 12 second period defining the radar transmission.

Note 2: The Channel Closing Transmission Time is comprised of 200 milliseconds starting at the beginning of the Channel Move Time plus any additional intermittent control signals required to facilitate Channel changes (an aggregate of 60 milliseconds) during the remainder of the 10 second period. The aggregate duration of control signals will not count quiet periods in between transmissions.

Note 3: During the U-NII Detection Bandwidth detection test, radar type 1 is used and for each frequency step the minimum percentage of detection is 90%. Measurements are performed with no data traffic.



8.2 DFS test results

8.2.1 Channel move time / channel closing transmission time

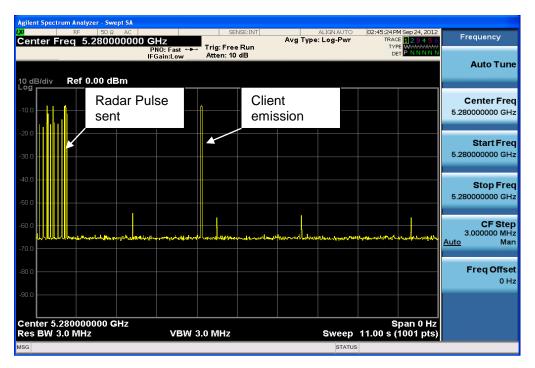
Description:

Channel Move Time. After a radar's presence is detected, all transmissions shall cease on the operating channel within 10 seconds. Transmissions during this period shall consist of normal traffic for a maximum of 200 ms after detection of the radar signal. In addition, intermittent management and control signals can be sent during the remaining time to facilitate vacating the operating channel.

Test Procedure:

Perform the test with one of the type 1 to type 4 short pulse radar waveforms.

Result: Channel 56

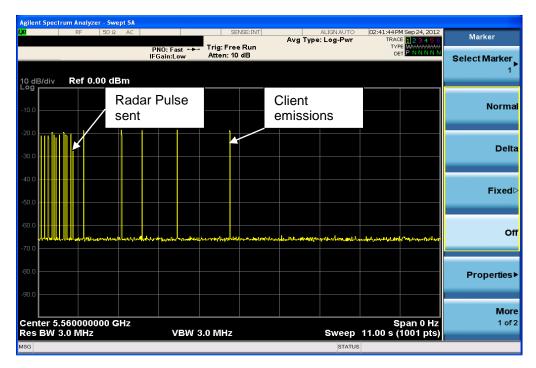


The arrow shows the time of the radar pulse. On the plot you can see that no transmissions occur from the AP after sending the radar burst. The time difference between the recognition of the radar burst by the AP and its last transmission is called as Channel Move Time (Limit: 10 s). The accumulated transmission time of the AP and for the slave device after detection of a radar signal is called channel closing transmission time (Limit: in total 200 ms + 60 ms).

The accumulated channel closing transmission time after 200ms of the slave device is less than 60 ms.



Result: Channel 112



The arrow shows the time of the radar pulse. On the plot you can see that no transmissions occur from the AP after sending the radar burst. The time difference between the recognition of the radar burst by the AP and its last transmission is called as Channel Move Time (Limit: 10 s). The accumulated transmission time of the AP and for the slave device after detection of a radar signal is called channel closing transmission time (Limit: in total 200 ms + 60 ms).

The accumulated channel closing transmission time after 200ms of the slave device is less than 60 ms.

Final verdict: Pass



8.2.2 Non-Occupancy Period

Description:

Non-occupancy Period. A channel that has been flagged as containing a radar system, either by a channel availability check or in-service monitoring, is subject to a non-occupancy period of at least 30 minutes. The non occupancy period starts at the time when the radar system is detected.

Test Procedure:

Client device is not permitted to transmit beacons on DFS frequencies.

1) Non-associated test:

The master has been off, monitor the analyzer on the test mode frequency that have been selected for testing, power up the client for 30 minutes to make sure no beacons have been transmitted.

2) Associated test:

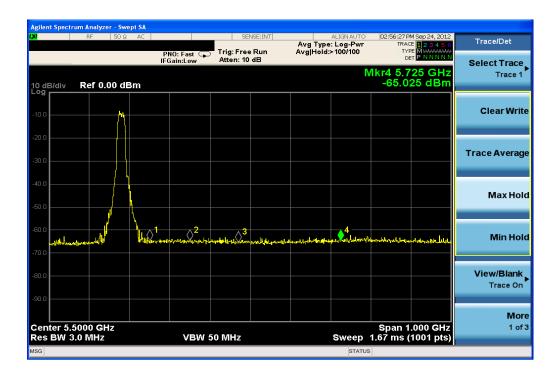
Associate the master and client and stream the movie as specified for non- occupancy test. Transmit Radar type 1; monitor the test frequency to make sure no beacons have been transmitted for 30 minutes.

Mode	Results	
Non-Associated	No Beacons transmit	
Associated	No transmissions	

Please refer to the following plots.



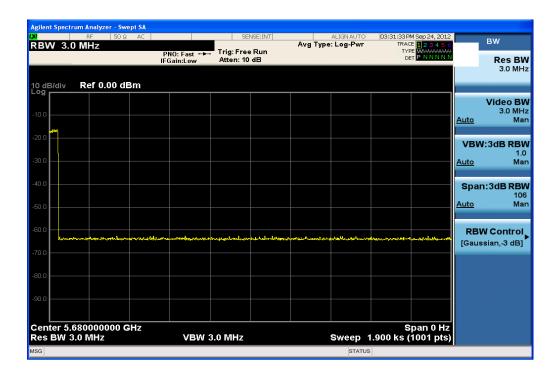
1) Non-associated:



The plot shows that no transmissions over a 30 minutes period occur within the DFS-Bands (between marker 1 and 2 and between Marker 3 and 4). The emissions above are not within the DFS-bands.



2) Associated:



In the plot above you can see, that the client does not transmit any emission within 30 minutes after having received the "stop transmit" order from the Access Point (DFS-Master).

Final verdict: Pass



9 Test equipment and ancillaries used for tests

Typically, the calibrations of the test apparatus are commissioned to and performed by an accredited calibration laboratory. The calibration intervals are determined in accordance with the DIN EN ISO/IEC 17025. In addition to the external calibrations, the laboratory executes comparison measurements with other calibrated test systems or effective verifications. Weekly chamber inspections and range calibrations are performed. Where possible, rf-generating and signalling equipment as well as measuring receivers and analyzers are connected to an external high-precision 10 MHz reference (GPS-based or rubidium frequency standard).

Typically, the calibrations of the test apparatus are commissioned to and performed by an accredited calibration laboratory. The calibration intervals are determined in accordance with the DIN EN ISO/IEC 17025. In addition to the external calibrations, the laboratory executes comparison measurements with other calibrated test systems or effective verifications. Weekly chamber inspections and range calibrations are performed. Where possible, rf-generating and signalling equipment as well as measuring receivers and analyzers are connected to an external high-precision 10 MHz reference (GPS-based or rubidium frequency standard).

In order to simplify the identification of the equipment used at some special tests, some items of test equipment and ancillaries can be provided with an identifier or number in the equipment list below (Lab/Item).

No.	Lab / Item	Equipment	Туре	Manufact.	Serial No.	INV. No Cetecom	Kind of Calibration	Last Calibration	Next Calibration
1	20	Directional Coupler	RBC90-10- SP	CMT	900687-008	300002117	ev		
2	21	Directional Coupler	RBC90-40- SP	CMT	900687-009	300002430	ne		
3	22	Directional Coupler	RBCC90N F-10	CMT	900687-020	300002432	ne		
4	23	Directional Coupler	RBCC90N F-40	CMT	900687-021	300002434	ne		
5	213	Attenuator SMA	K/SMA 20	Inmet Corp.		300002426	ev		
6	213	Attenuator SMA	K/SMA 30	Inmet Corp.		300002428	ev		
7	219	HF-Cable	KPS1533- 390-KPS	Insulated Wire		300002288	ev		
8	218	HF-Cable	KPS1533- 390-KPS	Insulated Wire		300002289	ev		
9	217	HF-Cable	KPS1533- 590-KPS	Insulated Wire		300002290	ev		
10	C005	HF-Cable 1.5 m 50 *	104PA	Suhner	1312/4PA	300002024	ev		
11	C009	HF-Cable 1.5 m 50 *	104PA	Suhner	1316/4PA	300002025	g		
12	C010	HF-Cable 1.5 m 50 *	104PA	Suhner	1298/4PA	300002026	g		
13	C004	HF-Cable 1.5 m 50 *	104PA	Suhner	1186/4PA	300002027	ev		
14	n. a.	Vektor Signal Generator	SMU200A	R&S	101633	300003496	k	19.08.2011	19.08.2014
15	n. a.	PXA Signal Analyzer 3 Hz - 50 GHz	N9030A PXA Signal Analyzer	Agilent	US51350267	300004338	k	12.01.2012	12.01.2013

Agenda: Kind of Calibration

k calibration / calibrated

- ne not required (k, ev, izw, zw not required)
- ev periodic self verification
- Ve long-term stability recognized
- vlkl! Attention: extended calibration interval
- NK! Attention: not calibrated

- EK limited calibration
- zw cyclical maintenance (external cyclical maintenance)
- izw internal cyclical maintenance
- g blocked for accredited testing
- *) next calibration ordered / currently in progress

10 Observations

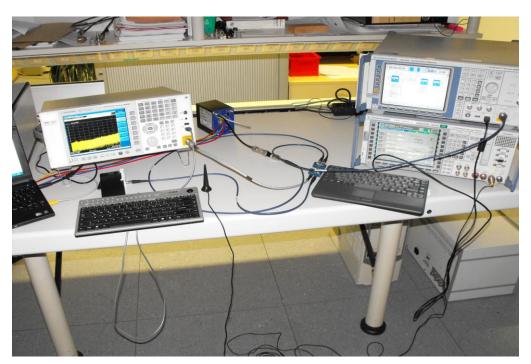
No observations exceeding those reported with the single test cases have been made.



Annex A Photographs of the test setup

Photo documentation:

Photo 1:





Annex B External photographs of the EUT

Photo documentation:

Photo 1:

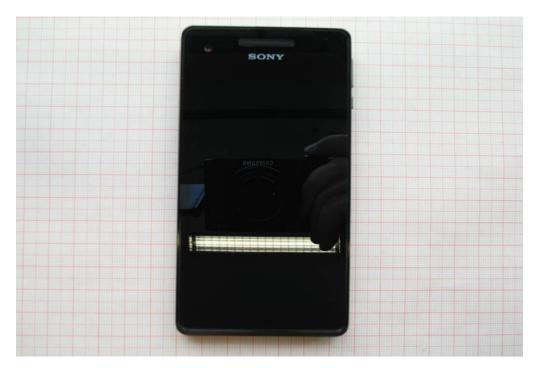


Photo 2:





Photo 3:

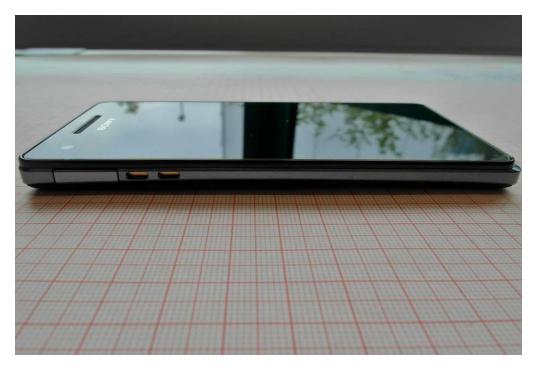


Photo 4:

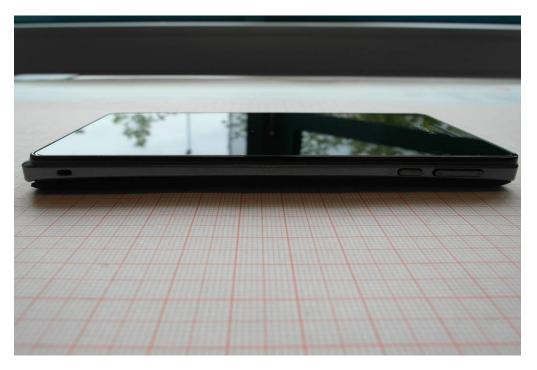




Photo 5:

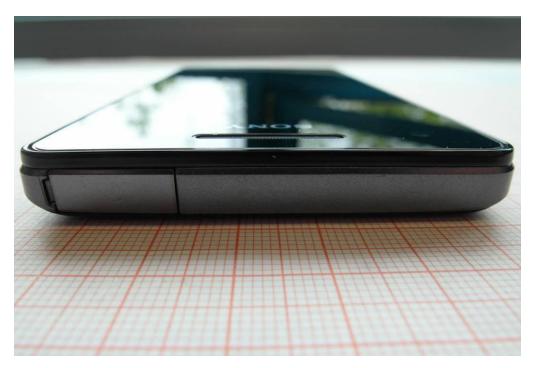


Photo 6:





Photo 7:



Photo 8:





Photo 9:





Annex C Internal photographs of the EUT

Photo documentation:

Photo 1:



Photo 2:





Photo 3:



Photo 4:

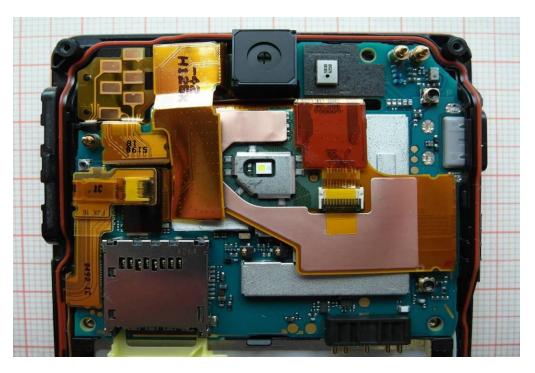




Photo 5:





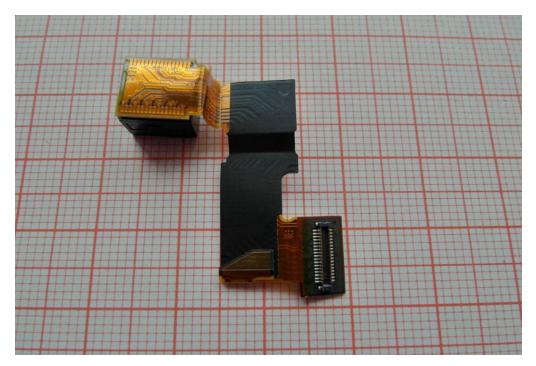




Photo 7:



Photo 8:

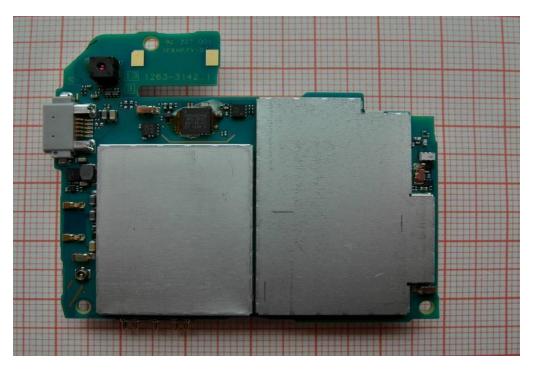




Photo 9:

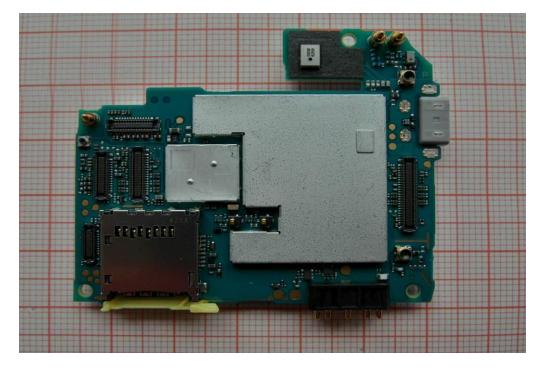


Photo 10:

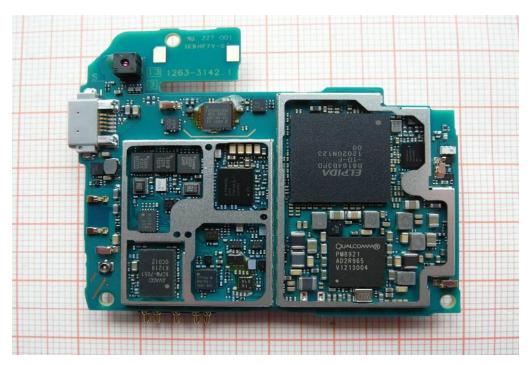




Photo 11:

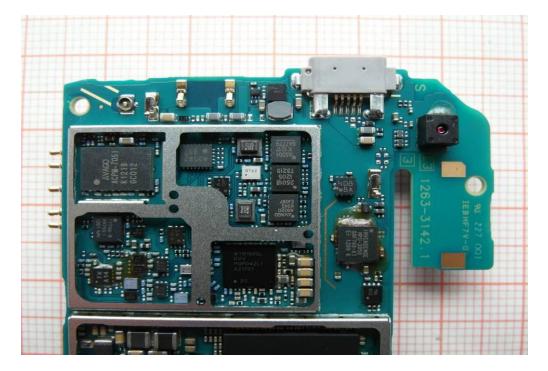


Photo 12:

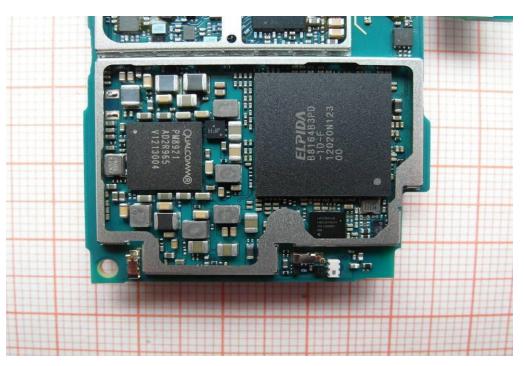




Photo 13:





Annex D Document history

Version	Applied changes	Date of release
1.0	Initial release	2012-10-01

Annex E Further information

<u>Glossary</u>

AVG	-	Average
DUT	-	Device under test
EMC	-	Electromagnetic Compatibility
EN	-	European Standard
EUT	-	Equipment under test
ETSI	-	European Telecommunications Standard Institute
FCC	-	Federal Communication Commission
FCC ID	-	Company Identifier at FCC
HW	-	Hardware
IC	-	Industry Canada
Inv. No.	-	Inventory number
N/A	-	Not applicable
PP	-	Positive peak
QP	-	Quasi peak
S/N	-	Serial number
SW	-	Software



Annex F Accreditation Certificate



Front side of certificate

Back side of certificate

Note:

The current certificate including annex is published on our website (see link below) or may be received from CETECOM ICT Services on request.

http://www.cetecom.com/fileadmin/de/CETECOM_D_Saarbruecken/accreditations_Jan_2010/DAKKS_Akkredi_ Urk_EN17025-En_incl_Annex.pdf